

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/779,754	OGUCHI ET AL.	
Examiner	Art Unit	
MARK A MAIS	2419	

SEARCHED					
Class	Subclass	Date	Examiner		
370	353 354 389	10/14/2008	MAM		
	392 395.1				
	401 410 422				
	426 466 467				
	473 474				

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
·	DATE	EXMR		
See Inventorship Search	12/11/2007	MAM		
See Attached Electronic Search	12/11/2007	MAM		
See Attached Electronic Search [updated]	10/14/2008	MAM		